



**HiPerFET™
MOSFET
Q2-Class**

IXFR 38N80Q2

V_{DSS} = 800 V
I_{D25} = 28 A
R_{DS(on)} = 240 mΩ

t_{rr} ≤ 250 ns

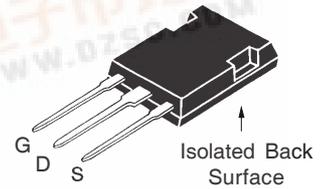
(Electrically Isolated Back Surface)



Preliminary Data Sheet

Symbol	Test Conditions	Maximum Ratings	ISOPLUS247 (IXFR)
V _{DSS}	T _J = 25°C to 150°C	800 V	V
V _{DGR}	T _J = 25°C to 150°C; R _{GS} = 1 MΩ	800 V	V
V _{GS}	Continuous	±30 V	V
V _{GSM}	Transient	±40 V	V
I _{D25}	T _C = 25°C	28 A	A
I _{DM}	T _C = 25°C, pulse width limited by T _{JM}	150 A	A
I _{AR}	T _C = 25°C	38 A	A
E _{AR}	T _C = 25°C	75 mJ	J
E _{AS}	T _C = 25°C	4.0 J	J
dv/dt	I _S ≤ I _{DM} , di/dt ≤ 100 A/μs, V _{DD} ≤ V _{DSS} , T _J ≤ 150°C, R _G = 2 Ω	20 V/ns	V/ns
P _D	T _C = 25°C	416 W	W
T _J		-55 ... +150 °C	°C
T _{JM}		150 °C	°C
T _{stg}		-55 ... +150 °C	°C
T _L	1.6 mm (0.063 in) from case for 10 s	300 °C	°C
V _{ISOL}	50/60 Hz, RMS, t = 1 min I _{SOL} = 1 mA, t = 1 s	2500 V~ 3000 V~	V~ V~
F _C	Mounting Force		
Weight		5 g	g

ISOPLUS247 (IXFR)



G = Gate
S = Source
D = Drain

Features

- Double metal process for low gate resistance
- Silicon chip on DCB substrate
 - High power dissipation
 - Isolated mounting surface
 - 2500V electrical isolation
- Epoxy meet UL 94 V-0, flammability classification
- Avalanche energy and current rated
- Fast intrinsic Rectifier

Advantages

- Easy assembly
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values		
		min.	typ.	max.
V _{DSS}	V _{GS} = 0 V, I _D = 3mA	800		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = 8 mA	2.0		4.5 V
I _{GSS}	V _{GS} = ±30 V _{DC} , V _{DS} = 0			±200 nA
I _{DSS}	V _{DS} = V _{DSS} V _{GS} = 0 V			T _J = 25°C 50 μA T _J = 125°C 2 mA
R _{DS(on)}	V _{GS} = 10 V, I _D = I _T Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %			240 mΩ



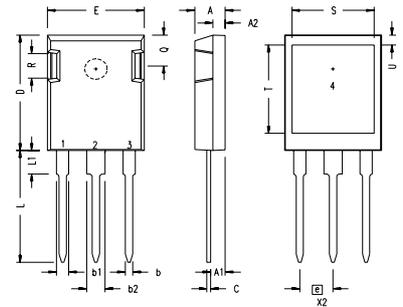
Symbol	Test Conditions	Characteristic Values ($T_J = 25^\circ\text{C}$, unless otherwise specified)		
		min.	typ.	max.
g_{fs}	$V_{DS} = 10\text{ V}; I_D = I_T$, pulse test	25	37	S
C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$		8340	pF
C_{oss}			890	pF
C_{rss}			175	pF
$t_{d(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = I_T$ $R_G = 1.0\ \Omega$ (External),		20	ns
t_r			16	ns
$t_{d(off)}$			60	ns
t_f			12	ns
$Q_{g(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = I_T$		190	nC
Q_{gs}			44	nC
Q_{gd}			88	nC
R_{thJC}			0.3	KW
R_{thCK}		0.15		KW

Source-Drain Diode

Characteristic Values
($T_J = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Test Conditions	Characteristic Values		
		min.	typ.	max.
I_S	$V_{GS} = 0\text{ V}$			38 A
I_{SM}	Repetitive; pulse width limited by T_{JM}			150 A
V_{SD}	$I_F = I_S, V_{GS} = 0\text{ V}$, Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $d \leq 2\%$			1.5 V
t_{rr}	$I_F = 25\text{ A}, -di/dt = 100\text{ A}/\mu\text{s}, V_R = 100\text{ V}$			250 ns
Q_{RM}			1	μC
I_{RM}			10	A

Notes: 1. Test current $I_T = 19\text{ A}$
2. See IXFK38N80Q2 data sheet for characteristic curves

ISOPLUS247 Outline


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.045	.055	1.14	1.40
b1	.075	.084	1.91	2.13
b2	.115	.123	2.92	3.12
C	.024	.031	0.61	0.80
D	.819	.840	20.80	21.34
E	.620	.635	15.75	16.13
e	.215 BSC		5.45 BSC	
L	.780	.800	19.81	20.32
L1	.150	.170	3.81	4.32
Q	.220	.244	5.59	6.20
R	.170	.190	4.32	4.83
S	.520	.540	13.21	13.72
T	.620	.640	15.75	16.26
U	.065	.080	1.65	2.03

- 1 - GATE
- 2 - DRAIN (COLLECTOR)
- 3 - SOURCE (EMITTER)
- 4 - NO CONNECTION

NOTE: This drawing will meet all dimensions requirement of JEDEC outline TO-247AD except screw hole.

Fig. 1. Output Characteristics @ 25°C

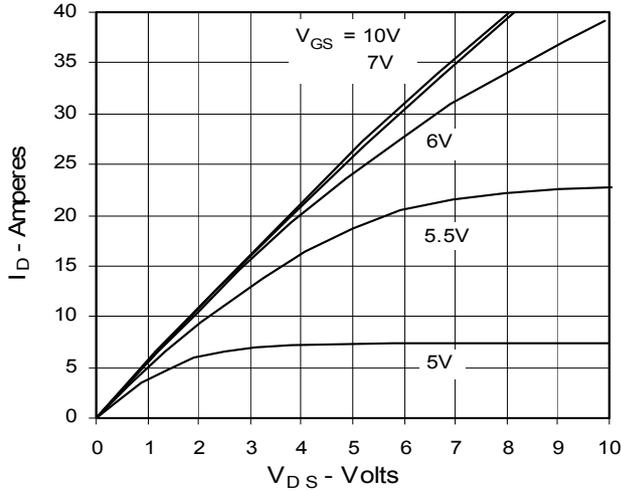


Fig. 2. Extended Output Characteristics @ 25°C

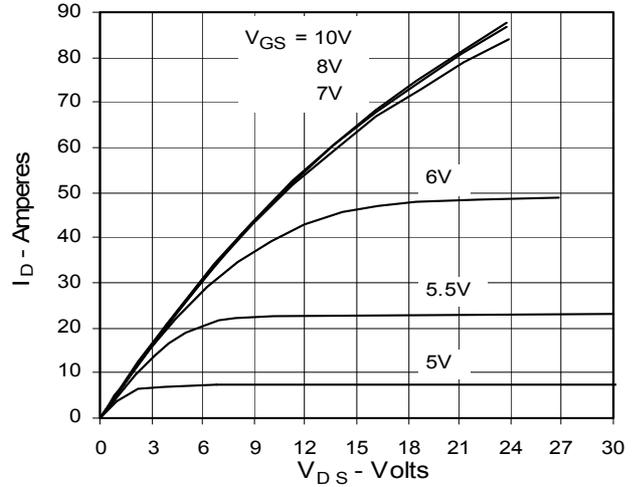


Fig. 3. Output Characteristics @ 125°C

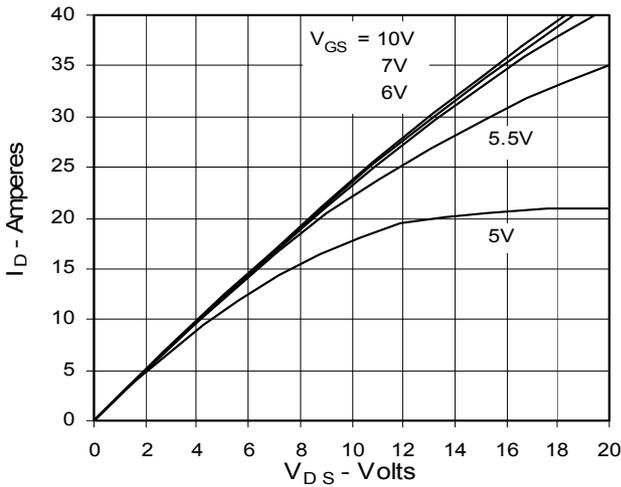


Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs. Junction Temperature

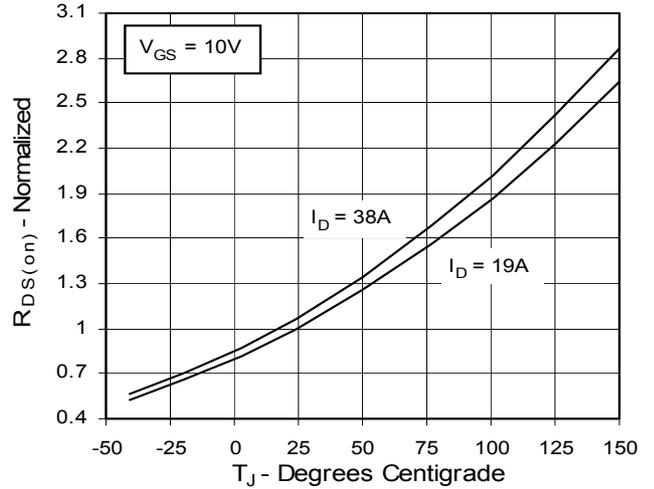


Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs. I_D

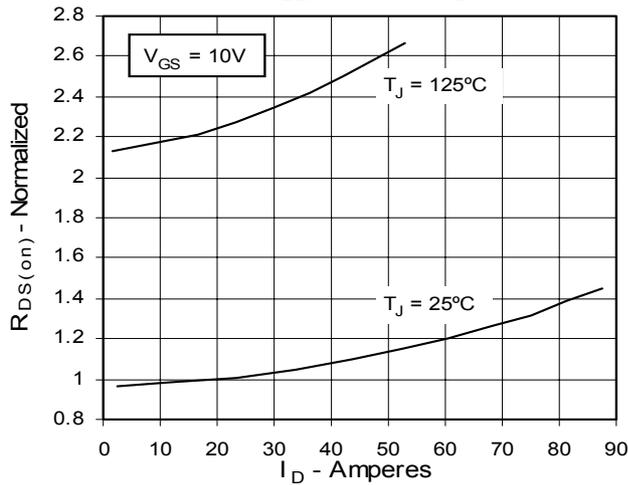


Fig. 6. Drain Current vs. Case Temperature

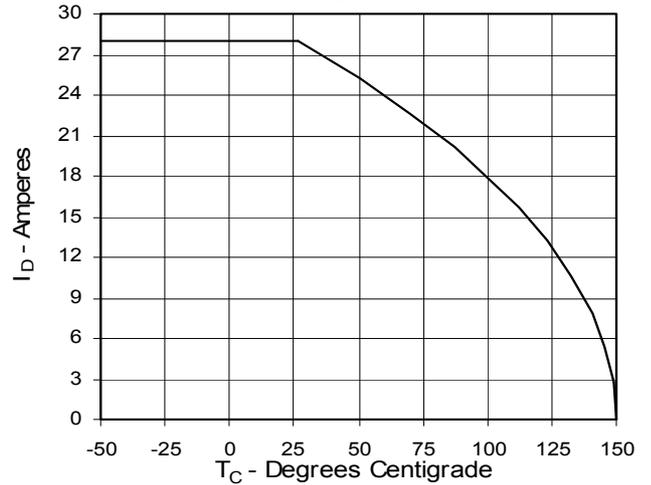


Fig. 7. Input Admittance

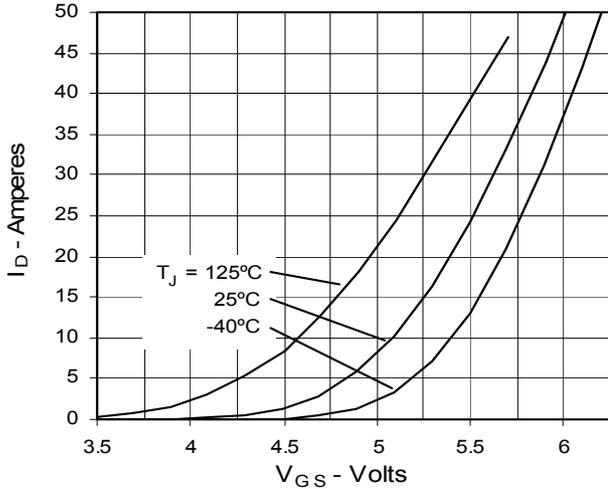


Fig. 8. Transconductance

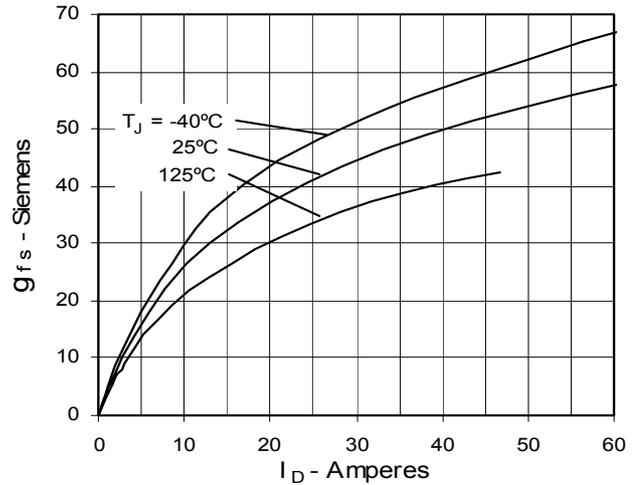


Fig. 9. Source Current vs. Source-To-Drain Voltage

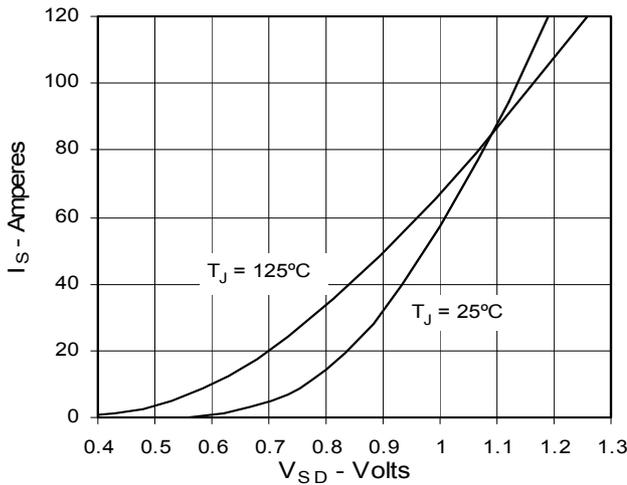


Fig. 10. Gate Charge

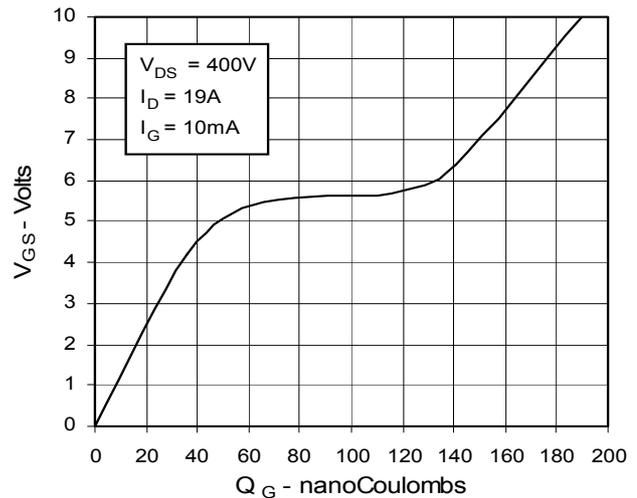


Fig. 11. Capacitance

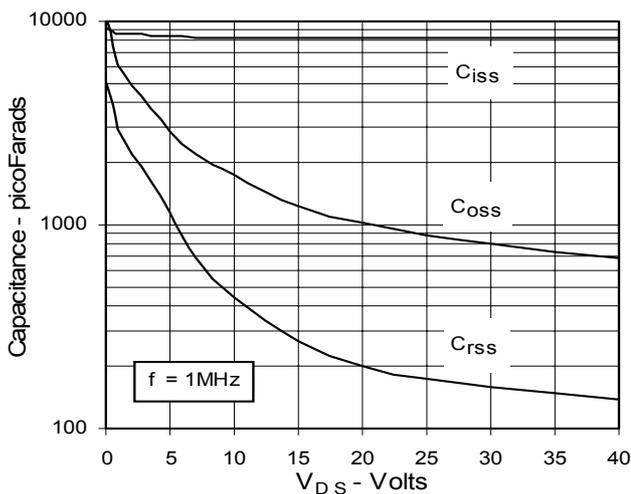


Fig. 12. Forward-Bias Safe Operating Area

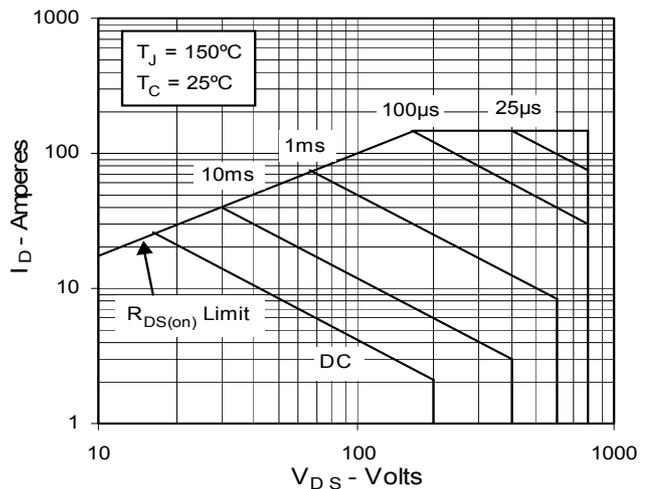


Fig. 13. Maximum Transient Thermal Resistance

